

GJ70T03

N-CHANNEL ENHANCEMENT MODE POWER MOSFET

BVDSS	25V
RDS(ON)	10mΩ
ID	60A

Description

The GJ70T03 provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

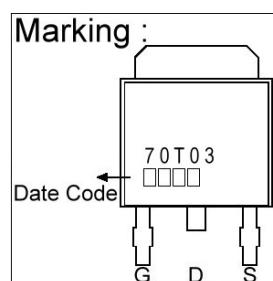
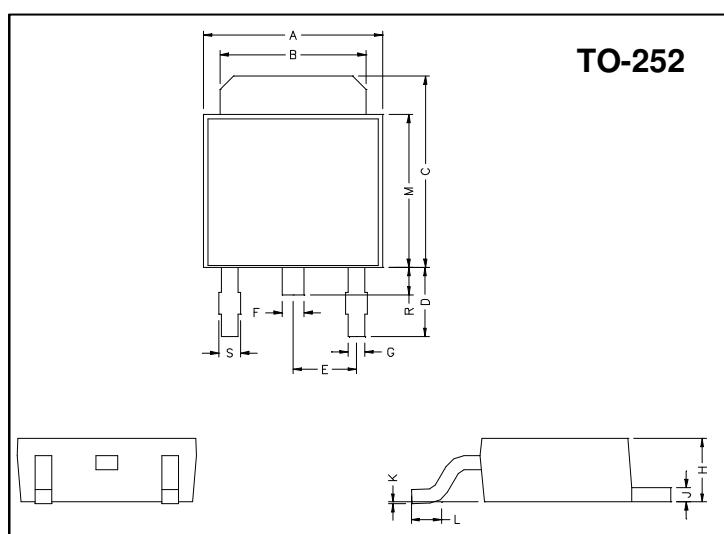
The TO-252 package is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.

Features

*Simple Drive Requirement

*Low Gate Charge

*Fast Switching

Package Dimensions

REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	6.40	6.80	G	0.50	0.70
B	5.20	5.50	H	2.20	2.40
C	6.80	7.20	J	0.45	0.55
D	2.40	3.00	K	0	0.15
E	2.30	REF.	L	0.90	1.50
F	0.70	0.90	M	5.40	5.80
S	0.60	0.90	R	0.80	1.20

Absolute Maximum Ratings

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V _{DS}	25	V
Gate-Source Voltage	V _{GS}	±20	V
Continuous Drain Current, V _{GS} @10V	I _D @ T _c =25°C	60	A
Continuous Drain Current, V _{GS} @10V	I _D @ T _c =100°C	43	A
Pulsed Drain Current ¹	I _{DM}	195	A
Total Power Dissipation	P _D @ T _c =25°C	53	W
Linear Derating Factor		0.36	W/°C
Operating Junction and Storage Temperature Range	T _j , T _{stg}	-55 ~ +175	°C

Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance Junction-case Max.	R _{thj-c}	2.8	°C/W
Thermal Resistance Junction-ambient Max.	R _{thj-a}	110	°C/W

GTM CORPORATION

ISSUED DATE :2005/02/21
REVISED DATE :2005/12/12B

Electrical Characteristics ($T_j = 25^\circ\text{C}$ unless otherwise specified)

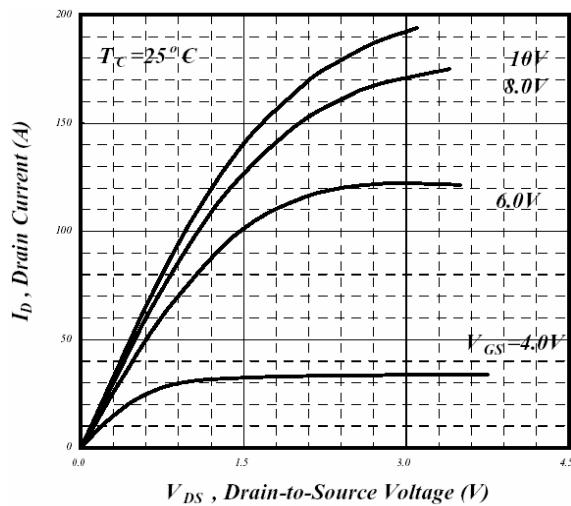
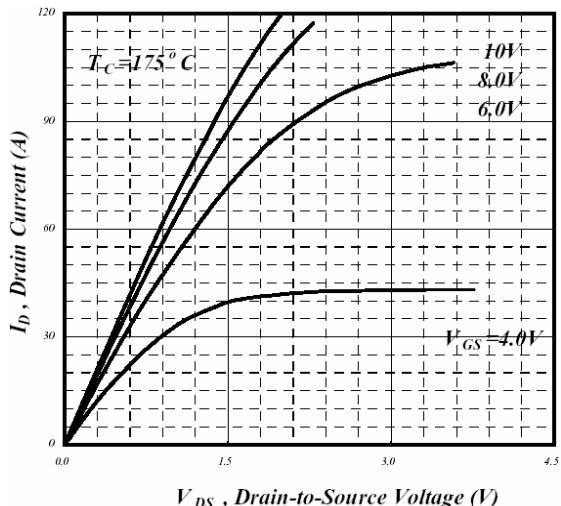
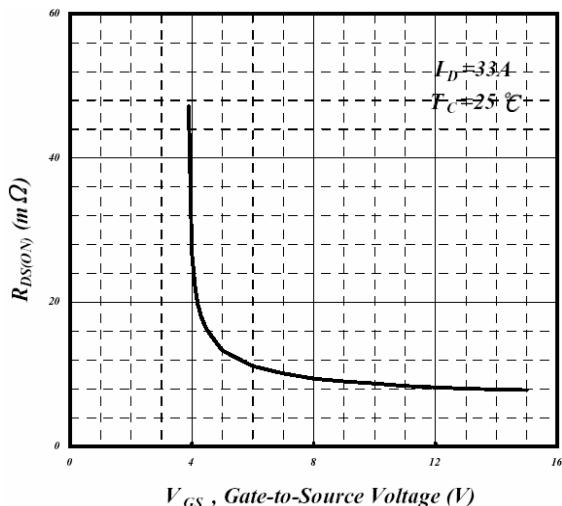
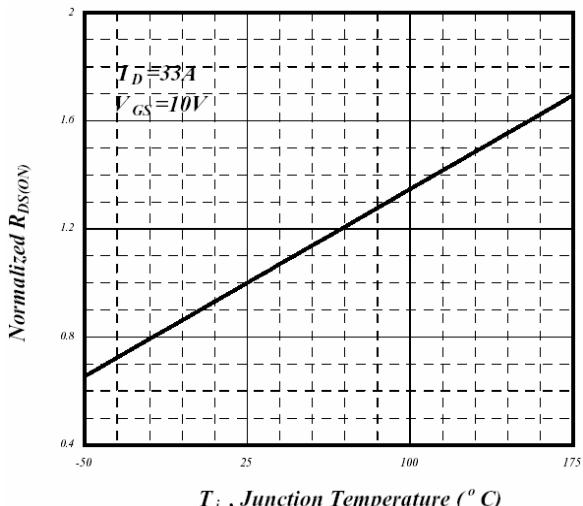
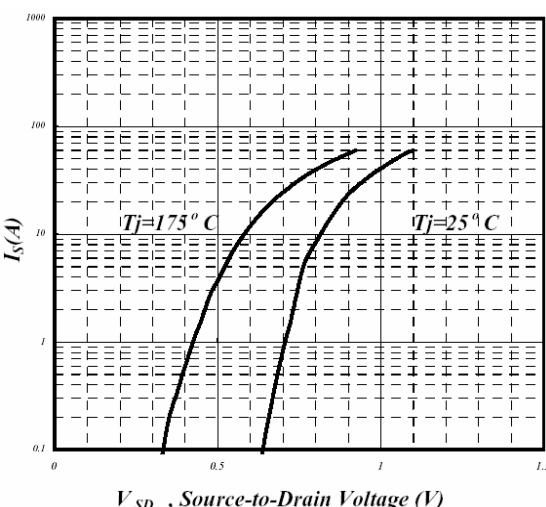
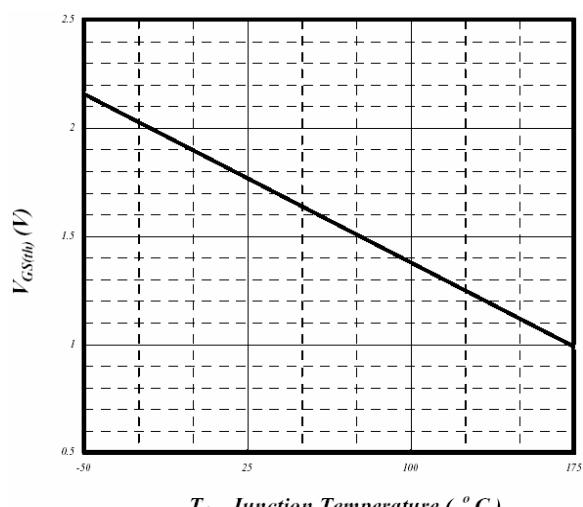
Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	BV_{DSS}	25	-	-	V	$\text{V}_{\text{GS}}=0$, $\text{I}_D=250\mu\text{A}$
Breakdown Voltage Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}} / \Delta T_j$	-	0.032	-	V/ $^\circ\text{C}$	Reference to 25°C , $\text{I}_D=1\text{mA}$
Gate Threshold Voltage	$\text{V}_{\text{GS}(\text{th})}$	1.0	-	3.0	V	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}$, $\text{I}_D=250\mu\text{A}$
Forward Transconductance	g_{fs}	-	35	-	S	$\text{V}_{\text{DS}}=10\text{V}$, $\text{I}_D=33\text{A}$
Gate-Source Leakage Current	I_{GSS}	-	-	± 100	nA	$\text{V}_{\text{GS}}= \pm 20\text{V}$
Drain-Source Leakage Current($T_j=25^\circ\text{C}$)	I_{DSS}	-	-	1	uA	$\text{V}_{\text{DS}}=25\text{V}$, $\text{V}_{\text{GS}}=0$
Drain-Source Leakage Current($T_j=175^\circ\text{C}$)		-	-	250	uA	$\text{V}_{\text{DS}}=20\text{V}$, $\text{V}_{\text{GS}}=0$
Static Drain-Source On-Resistance	$\text{R}_{\text{DS}(\text{ON})}$	-	-	10	m Ω	$\text{V}_{\text{GS}}=10\text{V}$, $\text{I}_D=33\text{A}$
		-	-	18		$\text{V}_{\text{GS}}=4.5\text{V}$, $\text{I}_D=20\text{A}$
Total Gate Charge ²	Q_g	-	16.5	-	nC	$\text{I}_D=33\text{A}$ $\text{V}_{\text{DS}}=20\text{V}$ $\text{V}_{\text{GS}}=4.5\text{V}$
Gate-Source Charge	Q_{gs}	-	5	-		
Gate-Drain ("Miller") Change	Q_{gd}	-	10.3	-		
Turn-on Delay Time ²	$\text{T}_{\text{d}(\text{on})}$	-	8.2	-	ns	$\text{V}_{\text{DS}}=15\text{V}$ $\text{I}_D=33\text{A}$ $\text{V}_{\text{GS}}=10\text{V}$ $\text{R}_G=3.3\Omega$ $\text{R}_D=0.45\Omega$
Rise Time	T_r	-	105	-		
Turn-off Delay Time	$\text{T}_{\text{d}(\text{off})}$	-	21.4	-		
Fall Time	T_f	-	8.5	-		
Input Capacitance	C_{iss}	-	1485	-	pF	$\text{V}_{\text{GS}}=0\text{V}$ $\text{V}_{\text{DS}}=25\text{V}$ $f=1.0\text{MHz}$
Output Capacitance	C_{oss}	-	245	-		
Reverse Transfer Capacitance	C_{rss}	-	170	-		

Source-Drain Diode

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Forward On Voltage ²	V_{SD}	-	-	1.3	V	$\text{I}_S=60\text{A}$, $\text{V}_{\text{GS}}=0\text{V}$, $T_j=25^\circ\text{C}$
Continuous Source Current (Body Diode)	I_S	-	-	60	A	$\text{V}_D=\text{V}_G=0\text{V}$, $\text{V}_S=1.3\text{V}$
Pulsed Source Current (Body Diode) ¹	I_{SM}	-	-	195	A	

Notes: 1. Pulse width limited by safe operating area.

2. Pulse width $\leq 300\text{us}$, duty cycle $\leq 2\%$.

Characteristics Curve**Fig 1. Typical Output Characteristics****Fig 2. Typical Output Characteristics****Fig 3. On-Resistance v.s. Gate Voltage****Fig 4. Normalized On-Resistance v.s. Junction Temperature****Fig 5. Forward Characteristics of Reverse Diode****Fig 6. Gate Threshold Voltage v.s. Junction Temperature**

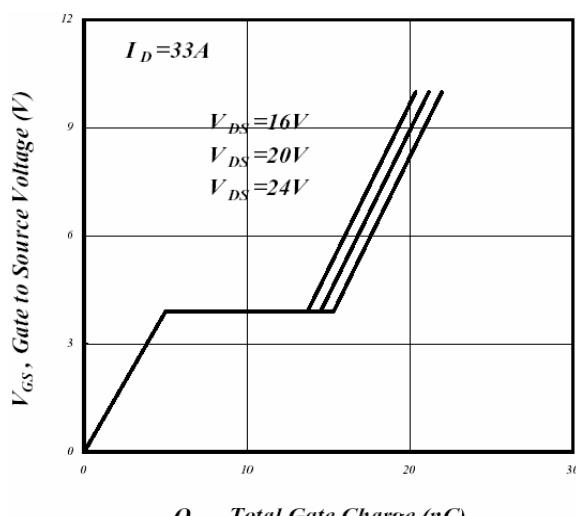


Fig 7. Gate Charge Characteristics

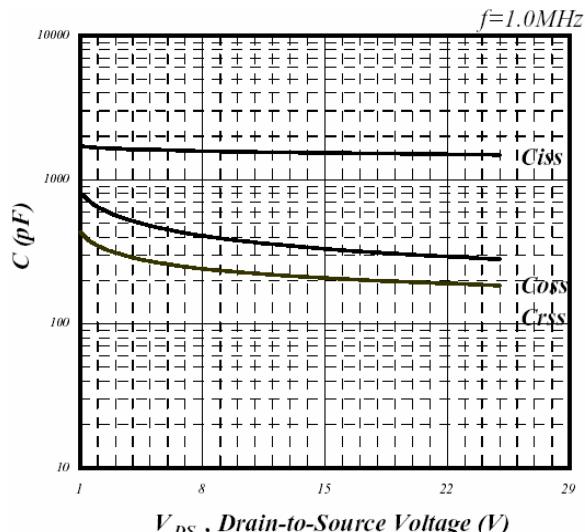


Fig 8. Typical Capacitance Characteristics

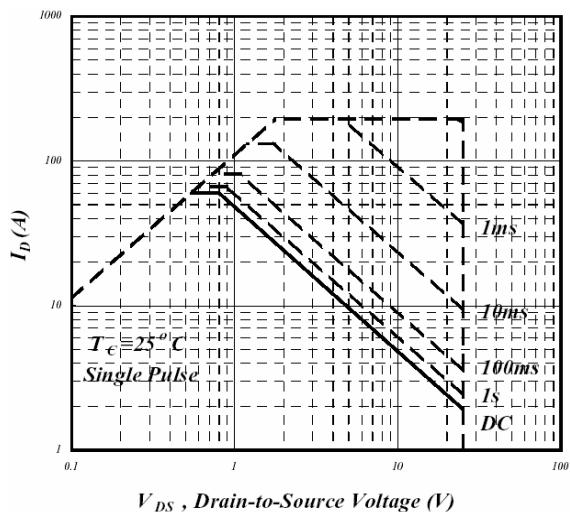


Fig 9. Maximum Safe Operating Area

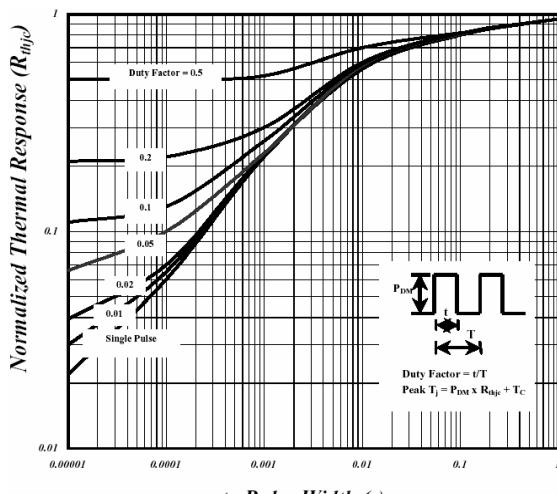


Fig 10. Effective Transient Thermal Impedance

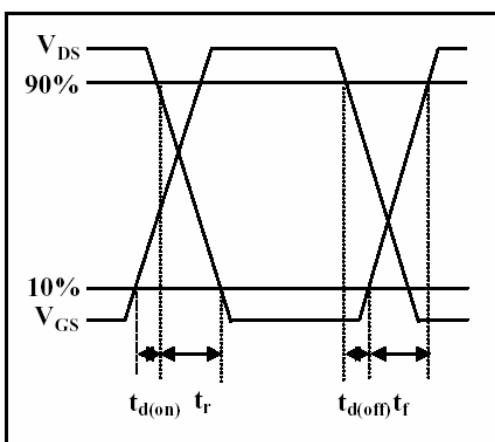


Fig 11. Switching Time Waveform

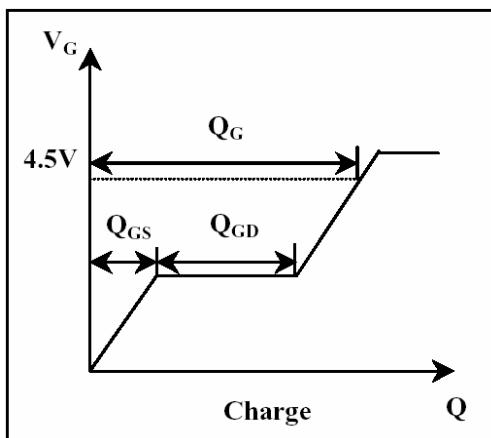


Fig 12. Gate Charge Waveform

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